TOSHIBA Transistor Silicon NPN Epitaxial Planar Type

2SC5092

VHF~UHF Band Low Noise Amplifier Applications

- Low noise figure, high gain.
- NF = 1.8dB, $|S_{21e}|^2 = 9.5dB$ (f = 2 GHz)

Absolute Maximum Ratings (Ta = 25°C)

| Characteristics | Symbol | Rating | Unit | |
|-----------------------------|------------------|---------|------|--|
| Collector-base voltage | V _{CBO} | 20 | V | |
| Collector-emitter voltage | V _{CEO} | 10 | V | |
| Emitter-base voltage | V _{EBO} | 1.5 | V | |
| Base current | Ι _Β | 20 | mA | |
| Collector current | ΙC | 40 | mA | |
| Collector power dissipation | P _C | 150 | mW | |
| Junction temperature | Tj | 125 | °C | |
| Storage temperature range | T _{stg} | -55~125 | °C | |

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).



Weight: 0.012 g (typ.)

Microwave Characteristics (Ta = 25°C)

| Characteristics | Symbol | Test Condition | Min | Тур. | Max | Unit | |
|----------------------|-------------------------------------|--|-----|------|----------|------|--|
| Transition frequency | f _T | $V_{CE} = 8 \text{ V}, \text{ I}_{C} = 20 \text{ mA}$ | 7 | 10 | _ | GHz | |
| Insertion gain | S _{21e} ² (1) | $V_{CE} = 8 \text{ V}, \text{ I}_{C} = 20 \text{ mA}, \text{ f} = 1 \text{ GHz}$ | 12 | 15 | | dB | |
| | S _{21e} ² (2) | $V_{CE} = 8 \text{ V}, \text{ I}_{C} = 20 \text{ mA}, \text{ f} = 2 \text{ GHz}$ | 6.5 | 9.5 | 9.5 — UB | | |
| Noiso figuro | NF (1) | $V_{CE} = 8 V$, $I_C = 5 mA$, $f = 1 GHz$ | | 1.4 | 2.5 | dB | |
| Noise ligure | NF (2) | $V_{CE} = 8 \text{ V}, \text{ I}_{C} = 5 \text{ mA}, \text{ f} = 2 \text{ GHz}$ | _ | 1.8 | 3 | | |

Electrical Characteristics (Ta = 25°C)

| Characteristics | Symbol | Symbol Test Condition | | Тур. | Max | Unit |
|------------------------------|-----------------------------|---|----|------|------|------|
| Collector cut-off current | I _{CBO} | $V_{CB} = 10 \text{ V}, \text{ I}_{E} = 0$ | _ | | 1 | μA |
| Emitter cut-off current | I _{EBO} | $V_{EB} = 1 \text{ V}, \text{ I}_{C} = 0$ | | _ | 1 | μA |
| DC current gain | h _{FE} (Note 1) | $V_{CE} = 8 \text{ V}, \text{ I}_{C} = 20 \text{ mA}$ | 50 | _ | 160 | |
| Output capacitance | C _{ob} | $V_{c-1} = 0$ f 1 MHz (Note 2) | _ | 0.7 | 1.1 | pF |
| Reverse transfer capacitance | C _{re} | $V_{CB} = 10 \text{ V}, 1E = 0, 1 = 1 \text{ MHZ} (NOTe 2)$ | _ | 0.45 | 0.95 | pF |

Note 1: hFE classification R: 50~100, O: 80~160

Note 2: Cre is measured by 3 terminal method with capacitance bridge.

Unit: mm

Marking





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$\label{eq:s-Parameter} S\text{-Parameter} \quad Z_O = 50 \ \Omega, \ Ta = 25^\circ C$

$V_{CE} = 8 V$, $I_C = 5 mA$

| Frequency | S | 11 | Sź | 21 | S | 12 | S | 22 |
|-----------|-------|--------|--------|-------|-------|------|-------|--------|
| (MHz) | Mag. | Ang. | Mag. | Ang. | Mag. | Ang. | Mag. | Ang. |
| 200 | 0.767 | -58.9 | 12.888 | 143.5 | 0.049 | 62.8 | 0.856 | -34.5 |
| 400 | 0.655 | -102.2 | 9.480 | 119.3 | 0.073 | 48.7 | 0.663 | -57.5 |
| 600 | 0.605 | -130.0 | 7.087 | 104.6 | 0.086 | 43.1 | 0.535 | -72.7 |
| 800 | 0.567 | -150.4 | 5.577 | 93.9 | 0.093 | 40.7 | 0.456 | -84.3 |
| 1000 | 0.547 | -166.4 | 4.548 | 86.0 | 0.098 | 41.1 | 0.407 | -93.8 |
| 1200 | 0.533 | -179.7 | 3.798 | 79.3 | 0.103 | 42.5 | 0.373 | -102.4 |
| 1400 | 0.528 | 169.1 | 3.268 | 76.9 | 0.109 | 44.1 | 0.346 | -110.3 |
| 1600 | 0.519 | 158.4 | 2.856 | 69.3 | 0.116 | 46.6 | 0.328 | -117.4 |
| 1800 | 0.520 | 148.3 | 2.551 | 65.1 | 0.124 | 48.9 | 0.314 | -123.0 |
| 2000 | 0.524 | 138.7 | 2.290 | 61.1 | 0.133 | 51.1 | 0.303 | -128.3 |

$V_{CE} = 8 V$, $I_C = 20 mA$

| Frequency | S | 11 | S2 | 21 | S | 12 | S | 22 |
|-----------|-------|--------|--------|-------|-------|------|-------|--------|
| (MHz) | Mag. | Ang. | Mag. | Ang. | Mag. | Ang. | Mag. | Ang. |
| 200 | 0.540 | -106.8 | 23.009 | 123.0 | 0.033 | 56.9 | 0.605 | -57.8 |
| 400 | 0.521 | -147.5 | 13.445 | 102.7 | 0.045 | 54.9 | 0.392 | -81.2 |
| 600 | 0.521 | -167.1 | 9.277 | 92.8 | 0.057 | 57.9 | 0.309 | -95.5 |
| 800 | 0.525 | -178.9 | 7.029 | 85.7 | 0.069 | 60.0 | 0.271 | -107.3 |
| 1000 | 0.526 | -168.8 | 5.651 | 80.0 | 0.082 | 62.5 | 0.250 | -117.9 |
| 1200 | 0.529 | -158.7 | 4.688 | 75.6 | 0.094 | 63.4 | 0.236 | -127.6 |
| 1400 | 0.531 | -148.5 | 4.011 | 71.6 | 0.106 | 64.5 | 0.225 | -136.2 |
| 1600 | 0.536 | -140.4 | 3.531 | 68.1 | 0.119 | 65.1 | 0.214 | -143.8 |
| 1800 | 0.539 | -131.7 | 3.159 | 64.7 | 0.133 | 65.5 | 0.201 | -149.8 |
| 2000 | 0.540 | -122.8 | 2.842 | 61.8 | 0.147 | 65.7 | 0.190 | -154.8 |











S_{22e}







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20070701-EN GENERAL

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